

Search Notes



Application/Control No.

10/516,991

Examiner

Sang Y. Paik

Applicant(s)/Patent under
Reexamination

WERMBTER ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	443.1- 468.2		
219	543- 548		
501	4-9 11	6/9/06	JP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
675T 764T 7624HEP	6/9/06	JP